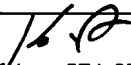


Notice of References Cited	Application/Control No. 10/541,401	Applicant(s)/Patent Under Reexamination FALCK ET AL.	
	Examiner  Kamran Afshar, 571-272-7796	Art Unit 2617	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0054821	03-2003	Kita et al.	455/435
*	B	US-2002/0193073	12-2002	Fujioka, Susumu	455/41
*	C	US-6,876,643	04-2005	Aggarwal et al.	370/338
*	D	US-2005/0141562	06-2005	Chen et al.	370/480
*	E	US-7,161,923	01-2007	Young, Song-Lin	370/338
*	F	US-6,842,460	01-2005	Oikkonen et al.	370/465
*	G	US-2003/0012173	01-2003	Rune, Johan	370/344
*	H	US-2006/0120301	06-2006	Falck et al.	370/254
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.